

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under  
Reexamination  
WU, SHYE-LIN

Examiner

Steven J. Fulk

Art Unit

2891

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,399,996	06-2002	Chang et al.	257/484
	B	US-5,262,669	11-1993	Wakatabe et al.	257/483
	C	US-6,309,929	10-2001	Hsu et al.	438/270
	D	US-6,426,541	07-2002	Chang et al.	257/472
	E	US-6,404,033	06-2002	Chang et al.	257/484
	F	US-6,740,951	05-2004	Tsui et al.	257/483
	G	US-2005/0029614	02-2005	Wu, Shye-Lin	257/471
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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